

<b>Notice of References Cited</b>	Application/Control No. 10/541,609	Applicant(s)/Patent Under Reexamination LAVOIE, ERIC	
	Examiner Thomas P. Noland	Art Unit 2856	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,331,034 A	05-1982	Takeda et al.	73/592 X
*	B	US-4,404,853 A	09-1983	Livingston, Waylon A.	73/622
*	C	US-5,243,862 A	09-1993	Latimer, Paul J.	73/622 X
*	D	US-5,359,898 A	11-1994	Latimer, Paul J.	73/622 X
*	E	US-5,506,503 A	04-1996	Cecco et al.	324/220
*	F	US-5,982,839 A	11-1999	Hatley, Kenneth J.	376/245
*	G	US-6,222,897 B1	04-2001	Hatley et al.	376/245
*	H	US-6,497,159 B1	12-2002	Lavoie, Eric	73/866.5
*	I	US-6,945,113 B2	09-2005	Siverling et al.	73/622
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 412396 A2	02-1991	European Patent	GUGEL, GEORG	G01N 29/24
	O	WO 2005/048271 A1	05-2005	WIPO	BHERER, J et al.	F16L 55/00
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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